

TOSHIBA CMOS Digital Integrated Circuit Silicon Monolithic

TC7MA157FK

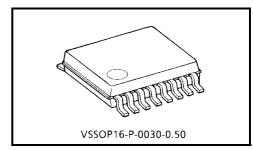
Low Voltage Quad 2-Channel Multiplexer with 3.6 V Tolerant Inputs and Outputs

The TC7MA157FK is a high performance CMOS multiplexer. Designed for use in 1.8, 2.5 or 3.3 V systems, it achieves high speed operation while maintaining the CMOS low power dissipation.

It is also designed with over voltage tolerant inputs and outputs up to $3.6\ V$.

It consists of four 2-input digital multiplexers with common select and strobe inputs.

When the \overline{ST} input is held "H" level, selection of data is inhibited and all the outputs become "L" level. The SELECT decoding determines whether the A or B inputs get routed to their corresponding Y outputs.



Weight: 0.02 g (typ.)

All inputs are equipped with protection circuits against static discharge.

Features

- Low voltage operation: $VCC = 1.8 \sim 3.6 \text{ V}$
- High speed operation: $t_{pd} = 3.0 \text{ ns (max) (VCC} = 3.0 \sim 3.6 \text{ V)}$

 $t_{pd} = 3.5 \text{ ns (max) (V}_{CC} = 2.3 \sim 2.7 \text{ V})$

 $t_{pd} = 7.0 \text{ ns (max) (VCC} = 1.8 \text{ V)}$

• Output current: IOH/IOL = ±24 mA (min) (VCC = 3.0 V)

 $IOH/IOL = \pm 18 \text{ mA (min) (VCC} = 2.3 \text{ V)}$

 $I_{OH}/I_{OL} = \pm 6 \text{ mA (min) (V}_{CC} = 1.8 \text{ V)}$

- Latch-up performance: ±300 mA
- ESD performance: Machine model $> \pm 200 \text{ V}$

Human body model > ±2000 V

- Package: VSSOP (US16)
- Power down protection is provided on all inputs and outputs.

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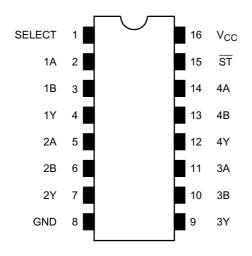
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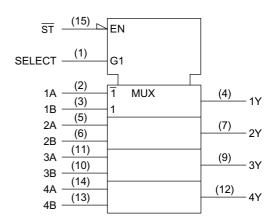
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Pin Assignment (top view)



IEC Logic Symbol



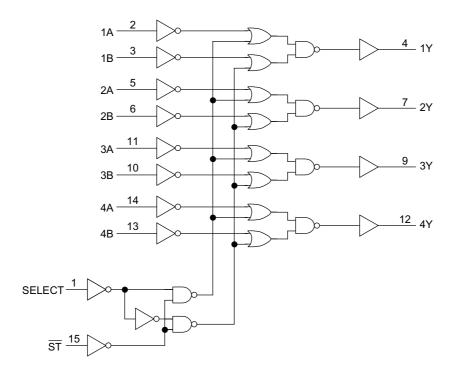
Truth Table

| | Inputs | | | | | | |
|----|--------|---|---|---|--|--|--|
| ST | SELECT | Α | В | Υ | | | |
| Н | Х | Х | Х | L | | | |
| L | L | L | Х | L | | | |
| L | L | Н | X | Н | | | |
| L | Н | X | L | L | | | |
| L | Н | Х | Н | Н | | | |

X: Don't care



System Diagram



Maximum Ratings

| Characteristics | Symbol Rating | | Unit |
|------------------------------------|-----------------------------------|------------------------------------|------|
| Power supply voltage | V _{CC} | -0.5~4.6 | V |
| DC input voltage | V _{IN} | -0.5~4.6 | V |
| DC output voltage | \/ - | -0.5~4.6 (Note1) | · V |
| DC output voltage | V _{OUT} | -0.5~V _{CC} + 0.5 (Note2) | V |
| Input diode current | I _{IK} | -50 | mA |
| Output diode current | I _{OK} | ±50 (Note3) | mA |
| DC output current | lout | ±50 | mA |
| Power dissipation | P _D | 180 | mW |
| DC V _{CC} /ground current | I _{CC} /I _{GND} | ±100 | mA |
| Storage temperature | T _{stg} | -65~150 | °C |

Note1: $V_{CC} = 0 V$

Note2: High or low state. $I_{\mbox{OUT}}$ absolute maximum rating must be observed.

Note3: $V_{OUT} < GND, V_{OUT} > V_{CC}$



Recommended Operating Range

| Characteristics | Symbol | Rating | Unit |
|--------------------------|----------------------------------|---------------------------|------|
| Supply voltage | V _{CC} | 1.8~3.6 | V |
| Supply voltage | VCC | 1.2~3.6 (Note4) | V |
| Input voltage | V _{IN} | -0.3~3.6 | V |
| Output voltage | Vout | 0~3.6 (Note5) | V |
| Output voltage | VOU1 | 0~V _{CC} (Note6) | V |
| | | ±24 (Note7) | |
| Output current | I _{OH} /I _{OL} | ±18 (Note8) | mA |
| | | ±6 (Note9) | |
| Operating temperature | T _{opr} | -40~85 | °C |
| Input rise and fall time | dt/dv | 0~10 (Note10) | ns/V |

Note4: Data retention only

Note5: $V_{CC} = 0 V$

Note6: High or low state

Note7: $V_{CC} = 3.0 \sim 3.6 \text{ V}$

Note8: $V_{CC} = 2.3 \sim 2.7 \text{ V}$

Note9: $V_{CC} = 1.8 \text{ V}$

Note10: $V_{IN} = 0.8 \sim 2.0 \text{ V}, V_{CC} = 3.0 \text{ V}$

Electrical Characteristics

DC Characteristics (Ta = -40~85°C, 2.7 V < V_{CC} \leq 3.6 V)

| Characteristics | | Symbol | Test Condition | | | Min Max | | Unit |
|---------------------------------|------------|------------------|--|---------------------------|---------------------|--------------------------|-------|------|
| G.1.a. a. s. s. s. | J. 1.00 | C yzc. | | | V _{CC} (V) | | ···· | 01 |
| Input voltage | High level | V _{IH} | | _ | 2.7~3.6 | 2.0 | _ | V |
| input voltage | Low level | V _{IL} | | _ | 2.7~3.6 | _ | 0.8 | V |
| | | | | I _{OH} = -100 μA | 2.7~3.6 | V _{CC} - 0.2 | _ | |
| | High level | V _{OH} | V _{IN} = V _{IH} or V _{IL} | $I_{OH} = -12 \text{ mA}$ | 2.7 | 2.2 | _ | |
| | | | | $I_{OH} = -18 \text{ mA}$ | 3.0 | 2.4 | _ | V |
| Output voltage Low lev | | | | I _{OH} = -24 mA | 3.0 | 2.2 | _ | |
| | | | $V_{IN} = V_{IH}$ or V_{IL} | $I_{OL} = 100 \mu A$ | 2.7~3.6 | _ | 0.2 | |
| | Lowlovel | VOI | | I _{OL} = 12 mA | 2.7 | _ | 0.4 | |
| | Low level | VOL | | I _{OL} = 18 mA | 3.0 | _ | 0.4 | |
| | | | | I _{OL} = 24 mA | 3.0 | _ | 0.55 | |
| Input leakage curre | nt | I _{IN} | V _{IN} = 0~3.6 V | | 2.7~3.6 | _ | ±5.0 | μА |
| Power off leakage current | | I _{OFF} | V _{IN} , V _{OUT} = 0~3.6 V | | 0 | _ | 10.0 | μА |
| Quiescent supply current | | laa | V _{IN} = V _{CC} or GND | | 2.7~3.6 | _ | 20.0 | |
| | | Icc | V _{CC} ≤ V _{IN} ≤ 3.6 V | | 2.7~3.6 | _ | ±20.0 | μΑ |
| Increase in I _{CC} per | input | Δl _{CC} | $V_{IH} = V_{CC} - 0.6 V$ | | 2.7~3.6 | | 750 | |



DC Characteristics (Ta = -40~85°C, 2.3 V \leq V_{CC} \leq 2.7 V)

| Characteristics | | Symbol | Test | Test Condition | | Min | Max | Unit |
|--|--------------------------|------------------|---|--------------------------|--------------------------------------|-----|----------|------|
| | | | | | V _{CC} (V) | | | |
| Input voltage | High level | V _{IH} | | _ | 2.3~2.7 | 1.6 | _ | V |
| input voltage | Low level | V _{IL} | | _ | 2.3~2.7 | _ | 0.7 | V |
| | | | I _{OH} = -100 μA | 2.3~2.7 | V _{CC} - 0.2 | _ | | |
| | High level | V _{OH} | $V_{IN} = V_{IH}$ or V_{IL} | $I_{OH} = -6 \text{ mA}$ | 2.3 | 2.0 | _ | V |
| Output voltage | | | | I _{OH} = -12 mA | 2.3 | 1.8 | _ | |
| | | | | I _{OH} = -18 mA | 2.3 | 1.7 | _ | |
| | | | I _{OL} = 100 μA | 2.3~2.7 | _ | 0.2 | | |
| | Low level | V _{OL} | V_{OL} $V_{IN} = V_{IH} \text{ or } V_{IL}$ | I _{OL} = 12 mA | 2.3 | _ | 0.4 | |
| | | | | I _{OL} = 18 mA | 2.3 | _ | 0.6 | |
| Input leakage curr | ent | I _{IN} | V _{IN} = 0~3.6 V | • | 2.3~2.7 | _ | ±5.0 | μΑ |
| Power off leakage current I _O | | I _{OFF} | V _{IN} , V _{OUT} = 0~3.6 V | | 0 | _ | 10.0 | μΑ |
| O decreased assembly assembly | | I _{CC} | $V_{IN} = V_{CC}$ or GND | | $N = V_{CC}$ or GND $2.3\sim2.7$ $-$ | _ | 20.0 | ^ |
| Quiescent supply | Quiescent supply current | | V _{CC} ≤ V _{IN} ≤ 3.6 V | | 2.3~2.7 | _ | ±20.0 μA | μΑ |

DC Characteristics (Ta = -40~85°C, 1.8 V \leq V_{CC} < 2.3 V)

| Characteri | stics | Symbol | Test Condition | | V _{CC} (V) | Min | Max | Unit |
|--------------------------|---------------------------|---|--|---------------------------|---------------------|--------------------------|--------------------------|-------------|
| Input voltago | High level | V _{IH} | | | 1.8~2.3 | 0.7 × V _{CC} | _ | V |
| Input voltage | Low level | V _{IL} | | | 1.8~2.3 | _ | 0.2 × V _{CC} | V |
| | High level | VoH | V _{IN} = V _{IH} or V _{IL} | I _{OH} = -100 μA | 1.8 | V _{CC} - 0.2 | _ | V |
| Output voltage | | | | I _{OH} = -6 mA | 1.8 | 1.4 | _ | |
| | Low level | V _{OL} | $V_{IN} = V_{IH}$ or V_{IL} | I _{OL} = 100 μA | 1.8 | _ | 0.2 | |
| | Low level | VOL | | I _{OL} = 6 mA | 1.8 | | 0.3 | |
| Input leakage curre | $I_{IN} V_{IN} = 0~3.6 V$ | | 1.8 | | ±5.0 | μΑ | | |
| Power off leakage of | urrent | I _{OFF} V _{IN} , V _{OUT} = 0~3.6 V | | 0 | _ | 10.0 | μΑ | |
| Quiescent supply current | | lcc - | $V_{IN} = V_{CC}$ or GND | | 1.8 | _ | 20.0 | пΔ |
| | | | $V_{CC} \le V_{IN} \le 3.6 \text{ V}$ | | 1.8 | _ | ±20.0 | μA -20.0 |



AC Characteristics (Ta = $-40\sim85$ °C, Input: $t_r = t_f = 2.0$ ns, $C_L = 30$ pF, $R_L = 500$ Ω)

| Characteristics | Symbol | Symbol Test Condition | | Min | Max | Unit |
|-----------------------------------|--------------------------------------|-----------------------|---------------------|-----|-----|------|
| | | | V _{CC} (V) | | | |
| Propagation delay time | + | | 1.8 | 1.0 | 7.0 | |
| (A, B-Y) | t _{pLH} t _{pHL} | Figure 1, Figure 2 | 2.5 ± 0.2 | 8.0 | 3.5 | ns |
| (4, 5 1) | трпс | | 3.3 ± 0.3 | 0.6 | 3.0 | |
| Drangetian delay time | 4 | | 1.8 | 1.0 | 9.0 | |
| Propagation delay time (SELECT-Y) | t _{pLH} t _{pHL} | Figure 1, Figure 2 | 2.5 ± 0.2 | 8.0 | 4.5 | ns |
| (SEEEGI-T) | | | 3.3 ± 0.3 | 0.6 | 3.5 | |
| Decreasion delevities | ^t pLH ^t pHL | | 1.8 | 1.0 | 9.0 | |
| Propagation delay time (ST -Y) | | Figure 1, Figure 2 | 2.5 ± 0.2 | 8.0 | 4.5 | ns |
| (31-1) | | | 3.3 ± 0.3 | 0.6 | 3.5 | |
| Output to output skew | t _{osLH} | | 1.8 | _ | 0.5 | |
| | | (Note11) | 2.5 ± 0.2 | _ | 0.5 | ns |
| | | | 3.3 ± 0.3 | _ | 0.5 | |

For $C_L = 50\ pF$, add approximately 300 ps to the AC maximum specification.

Note11: This parameter is guaranteed by design.

 $(t_{OSLH} = |t_{DLHm} - t_{DLHn}|, t_{OSHL} = |t_{DHLm} - t_{DHLn}|)$

Dynamic Switching Characteristics (Ta = 25°C, Input: $t_r = t_f = 2.0$ ns, $C_L = 30$ pF)

| Characteristics | Symbol | Test Condition | | | Тур. | Unit |
|--|------------------|---|---------|---------------------|-------|-------|
| Characteristics | Syllibol | | | V _{CC} (V) | | Offic |
| | | $V_{IH} = 1.8 \text{ V}, V_{IL} = 0 \text{ V}$ (N | lote12) | 1.8 | 0.25 | |
| Quiet output maximum dynamic V _{OL} | V _{OLP} | $V_{IH} = 2.5 \text{ V}, V_{IL} = 0 \text{ V}$ (N | lote12) | 2.5 | 0.6 | V |
| | | $V_{IH} = 3.3 \text{ V}, V_{IL} = 0 \text{ V}$ (N | lote12) | 3.3 | 8.0 | |
| | V _{OLV} | $V_{IH} = 1.8 \text{ V}, V_{IL} = 0 \text{ V}$ (N | lote12) | 1.8 | -0.25 | V |
| Quiet output minimum dynamic V _{OL} | | $V_{IH} = 2.5 \text{ V}, V_{IL} = 0 \text{ V}$ (N | lote12) | 2.5 | -0.6 | |
| | | $V_{IH} = 3.3 \text{ V}, V_{IL} = 0 \text{ V}$ (N | lote12) | 3.3 | -0.8 | |
| | | $V_{IH} = 1.8 \text{ V}, V_{IL} = 0 \text{ V}$ (N | lote12) | 1.8 | 1.5 | |
| Quiet output minimum dynamic V _{OH} | V _{OHV} | $V_{IH} = 2.5 \text{ V}, V_{IL} = 0 \text{ V}$ (N | lote12) | 2.5 | 1.9 | V |
| | | $V_{IH} = 3.3 \text{ V}, V_{IL} = 0 \text{ V}$ (N | lote12) | 3.3 | 2.2 | |

Note12: This parameter is guaranteed by design.

Capacitive Characteristics (Ta = 25°C)

| Characteristics | Symbol | Test Condition | n | V _{CC} (V) | Тур. | Unit |
|-------------------------------|-----------------|--------------------------|----------|---------------------|------|------|
| Input capacitance | C _{IN} | _ | | 1.8, 2.5, 3.3 | 6 | pF |
| Power dissipation capacitance | C _{PD} | f _{IN} = 10 MHz | (Note13) | 1.8, 2.5, 3.3 | 20 | pF |

Note13: C_{PD} is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load.

Average operating current can be obtained by the equation:

 $I_{CC (opr)} = C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC}$

AC Test Circuit

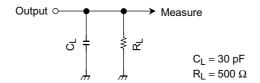
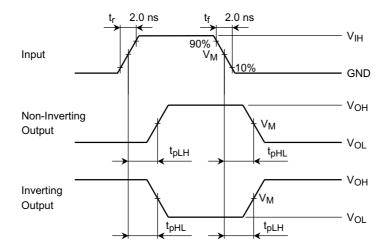


Figure 1

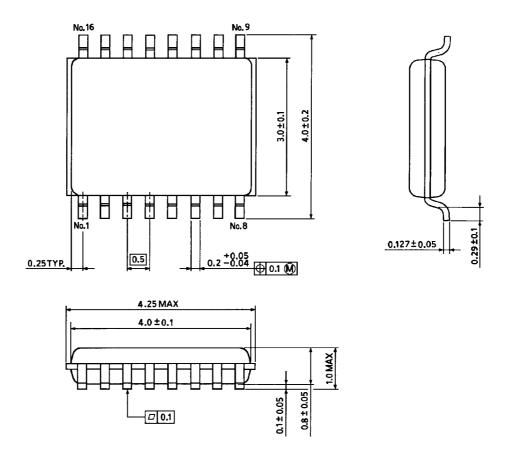
AC Waveform



| Symbol | V _{CC} | | | | | | |
|-----------------|------------------------|--------------------|--------------------|--|--|--|--|
| Symbol | $3.3\pm0.3~\textrm{V}$ | 2.5 ± 0.2 V | 1.8 V | | | | |
| V _{IH} | 2.7 V | V _{CC} | V _{CC} | | | | |
| V _M | 1.5 V | V _{CC} /2 | V _{CC} /2 | | | | |

Figure 2 t_{pLH}, t_{pHL}

Package Dimensions



Weight: 0.02 g (typ.)